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| Notice of References Cited | Application/Control No. 09/642,221 | Applicant(s)/Patent Under Reexamination ARISAWA ET AL. | |
| | Examiner Charles N. Appiah | Art Unit 2617 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-5,926,624 | 07-1999 | Katz et al. | 709/217 |
| * | B | US-6,516,466 | 02-2003 | Jackson, Vincent C. | 725/62 |
| * | C | US-6,587,684 | 07-2003 | Hsu et al. | 455/419 |
| * | D | US-6,640,306 | 10-2003 | Tone et al. | 726/4 |
| * | E | US-6,871,048 | 03-2005 | Takagaki, Hirokazu | 455/66.1 |
| * | F | US-7,039,686 | 05-2006 | Arisawa et al. | 709/219 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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